



YOUSHANG SEMICONDUCTOR

设计研发新型功率器件

各类小信号开关

中低压及高压大电流等场效应管

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企业微信二维码



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Product Summary

BV _{DSS}	R _{DS(ON)} Max	I _D Max T _A = +25°C
-20V	30mΩ @ V _{GS} = -4.5V	-6.0A
	39mΩ @ V _{GS} = -2.5V	-5.5A

Features and Benefits

- Low Input Capacitance
- Low On-Resistance
- Fast Switching Speed
- ESD Protected

Description and Applications

This MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) yet maintain superior switching performance, making it ideal for high-efficiency power-management applications.

- DC-DC converters
- Motor controls
- Power-management functions
- Analog switches

Mechanical Data

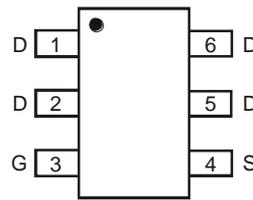
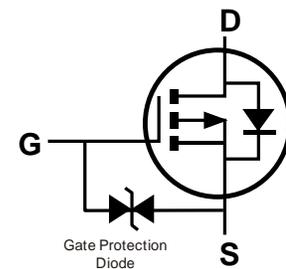
- Package: TSOT26
- Package Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish – Matte Tin Annealed over Copper Lead-Frame; Solderable per MIL-STD-202, Method 208 
- Weight: 0.013 grams (Approximate)



TSOT26



Top View


 Top View
 Pin-Out


Equivalent Circuit

Maximum Ratings (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-20	V
Gate-Source Voltage	V_{GSS}	± 8	V
Continuous Drain Current (Note 5) $V_{GS} = -4.5\text{V}$	I_D	$T_A = +25^\circ\text{C}$ Steady State	-6.0 A
		$T_A = +70^\circ\text{C}$	-5.0 A
Pulsed Drain Current (10 μs Pulse, Duty Cycle = 1%)	I_{DM}	-40	A
Continuous Source-Drain Diode Current (Note 5)	I_S	-2,2	A
Avalanche Current (Note 6) $L = 0.1\text{mH}$	I_{AS}	-21	A
Avalanche Energy (Note 6) $L = 0.1\text{mH}$	E_{AS}	23	mJ

Thermal Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 7)	P_D	$T_A = +25^\circ\text{C}$	1.1
		$T_A = +70^\circ\text{C}$	0.7
Thermal Resistance, Junction to Ambient (Note 7)	Steady State $R_{\theta JA}$	108	$^\circ\text{C/W}$
Total Power Dissipation (Note 5)	P_D	$T_A = +25^\circ\text{C}$	1.5
		$T_A = +70^\circ\text{C}$	1.0
Thermal Resistance, Junction to Ambient (Note 5)	Steady State $R_{\theta JA}$	81	$^\circ\text{C/W}$
Thermal Resistance, Junction to Case (Note 5)	Steady State $R_{\theta JC}$	16	
Operating and Storage Temperature Range	T_J, T_{STG}	-55 to +150	$^\circ\text{C}$

Electrical Characteristics (@ $T_A = +25^\circ\text{C}$, unless otherwise specified.)

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV_{DSS}	-20	—	—	V	$V_{GS} = 0\text{V}, I_D = -250\mu\text{A}$
Zero Gate Voltage Drain Current $T_J = +25^\circ\text{C}$	I_{DSS}	—	—	-1	μA	$V_{DS} = -16\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	—	—	± 10	μA	$V_{GS} = \pm 8\text{V}, V_{DS} = 0\text{V}$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$V_{GS(TH)}$	-0.4	—	-1.0	V	$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(ON)}$	—	24	30	m Ω	$V_{GS} = -4.5\text{V}, I_D = -6.4\text{A}$
			31	39		$V_{GS} = -2.5\text{V}, I_D = -4.8\text{A}$
			41	58		$V_{GS} = -1.8\text{V}, I_D = -2.5\text{A}$
Diode Forward Voltage	V_{SD}	—	-0.7	-1.2	V	$V_{GS} = 0\text{V}, I_S = -1.0\text{A}$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C_{iss}	—	1,808	—	pF	$V_{DS} = -15\text{V}, V_{GS} = 0\text{V}$ $f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	—	155	—		
Reverse Transfer Capacitance	C_{rss}	—	117	—		
Gate Resistance	R_g	—	32	—	Ω	$V_{DS} = 0\text{V}, V_{GS} = 0\text{V}, f = 1\text{MHz}$
Total Gate Charge ($V_{GS} = -4.5\text{V}$)	Q_g	—	20.5	—	nC	$V_{DS} = -10\text{V}, V_{GS} = -4.5\text{V}$ $I_D = -4.0\text{A}$
Gate-Source Charge	Q_{gs}	—	2.8	—		
Gate-Drain Charge	Q_{gd}	—	4.1	—		
Turn-On Delay Time	$t_{D(ON)}$	—	9.1	—	ns	$V_{DS} = -10\text{V}, V_{GS} = -4.5\text{V}$ $R_g = 6\Omega, I_D = -1.0\text{A}$
Turn-On Rise Time	t_R	—	12.3	—		
Turn-Off Delay Time	$t_{D(OFF)}$	—	120	—		
Turn-Off Fall Time	t_F	—	54	—		
Reverse Recovery Time	t_{RR}	—	23.1	—	ns	$I_F = -1.0\text{A}, dI/dt = 100\text{A}/\mu\text{s}$
Reverse Recovery Charge	Q_{RR}	—	8.3	—	nC	$I_F = -1.0\text{A}, dI/dt = 100\text{A}/\mu\text{s}$

- Notes:
- Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate.
 - I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep $T_J = +25^\circ\text{C}$.
 - Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
 - Short duration pulse test used to minimize self-heating effect.
 - Guaranteed by design. Not subject to product testing

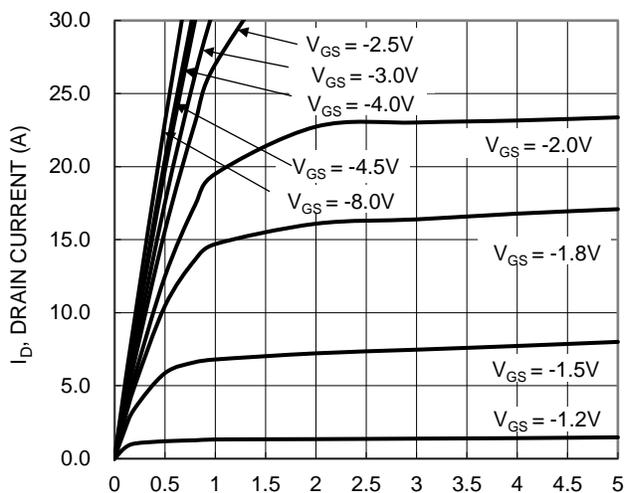


Figure 1. Typical Output Characteristic

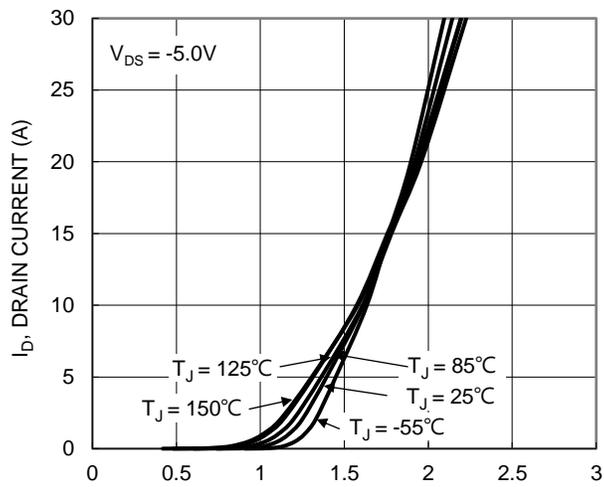


Figure 2. Typical Transfer Characteristic

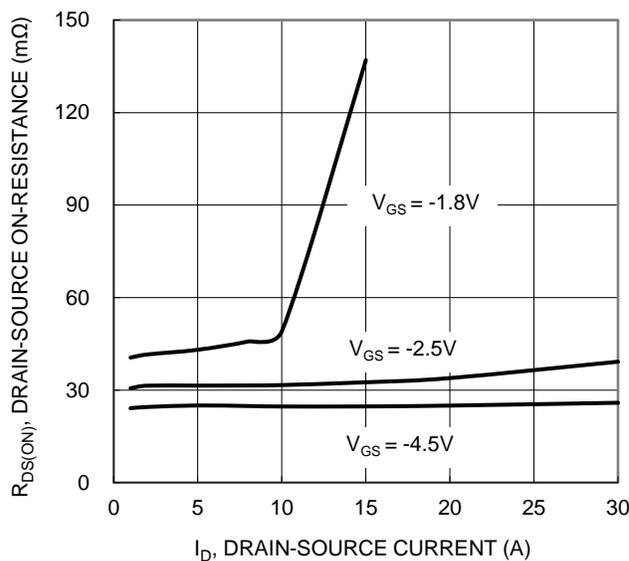


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

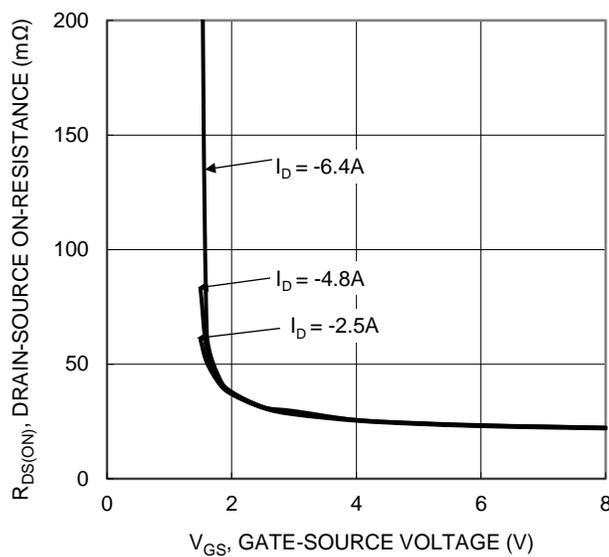


Figure 4. Typical Transfer Characteristic

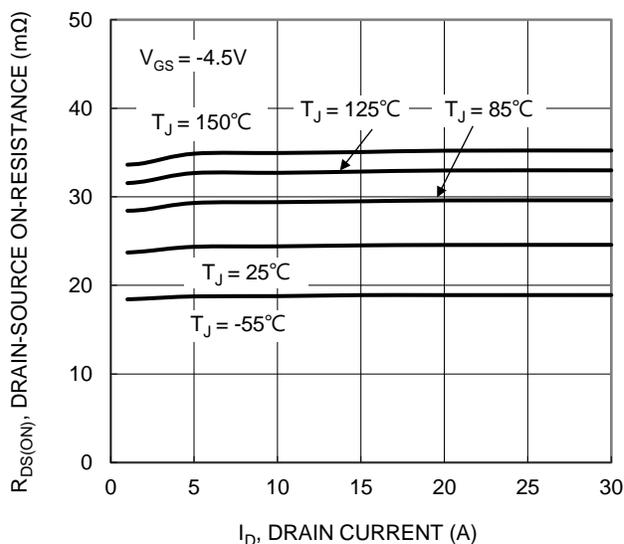


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

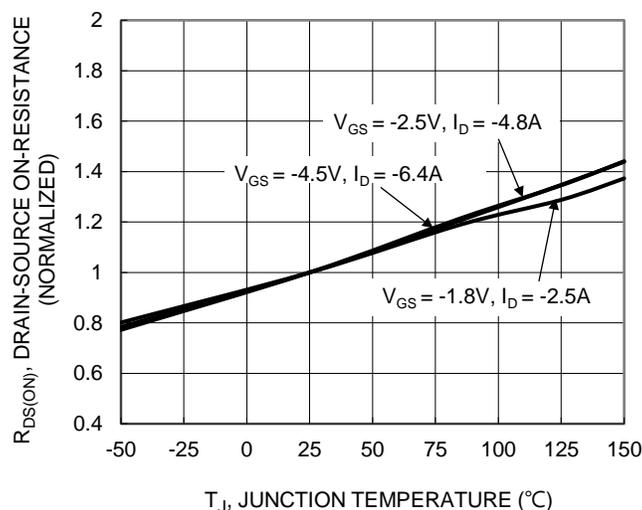


Figure 6. On-Resistance Variation with Temperature

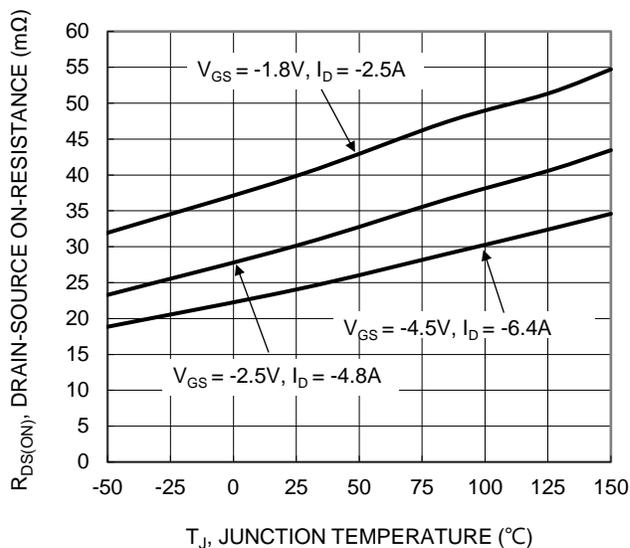


Figure 7. On-Resistance Variation with Temperature

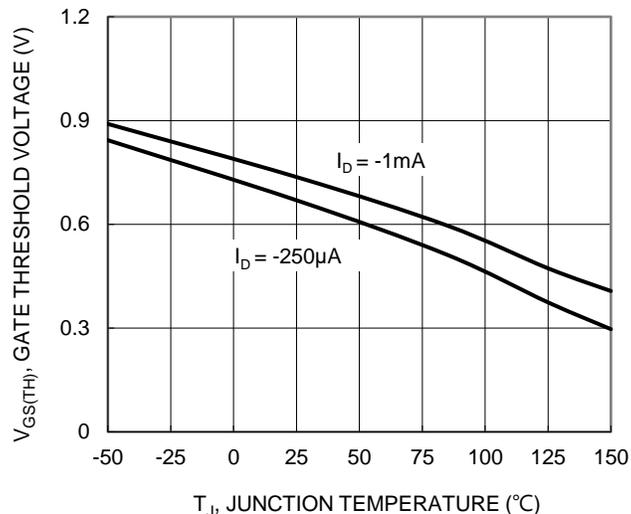


Figure 8. Gate Threshold Variation vs. Junction Temperature

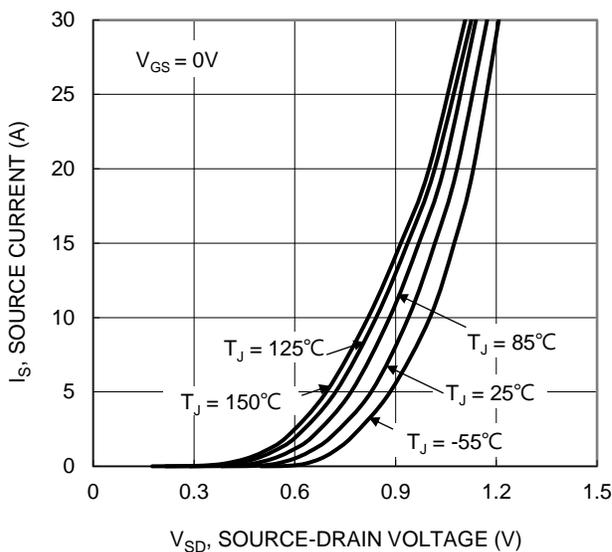


Figure 9. Diode Forward Voltage vs. Current

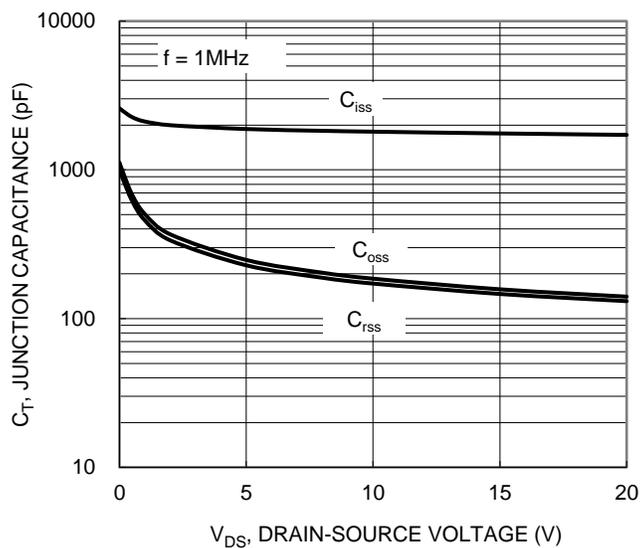


Figure 10. Typical Junction Capacitance

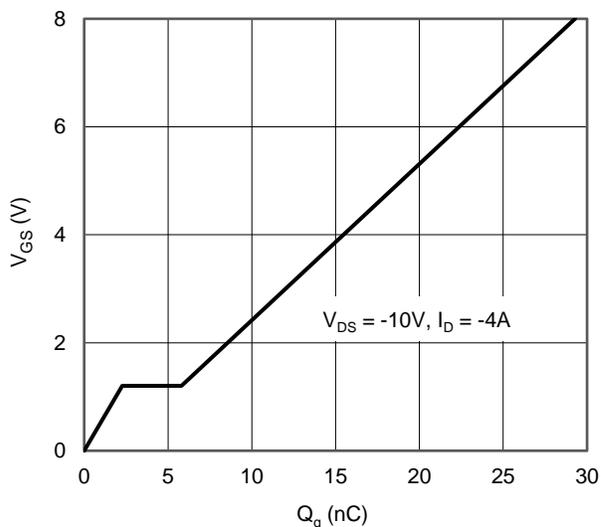


Figure 11. Gate Charge

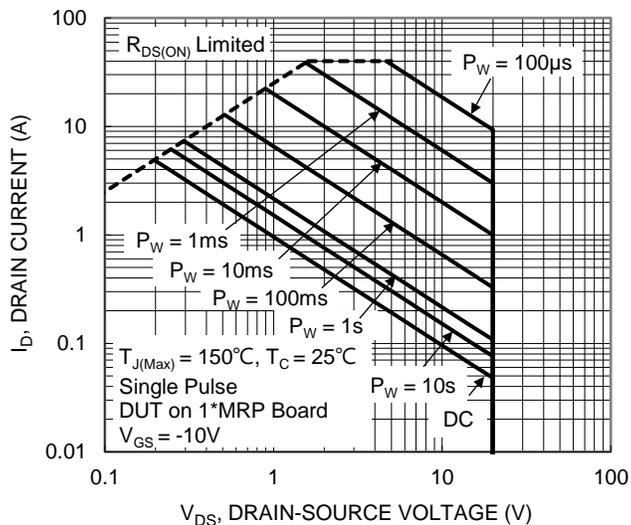


Figure 12. SOA, Safe Operation Area

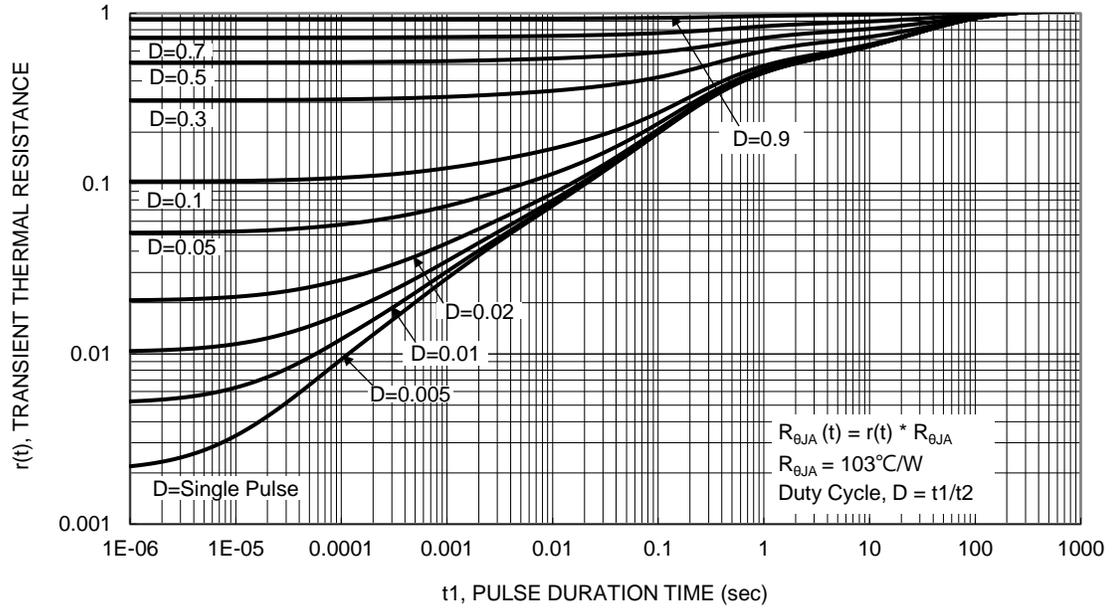
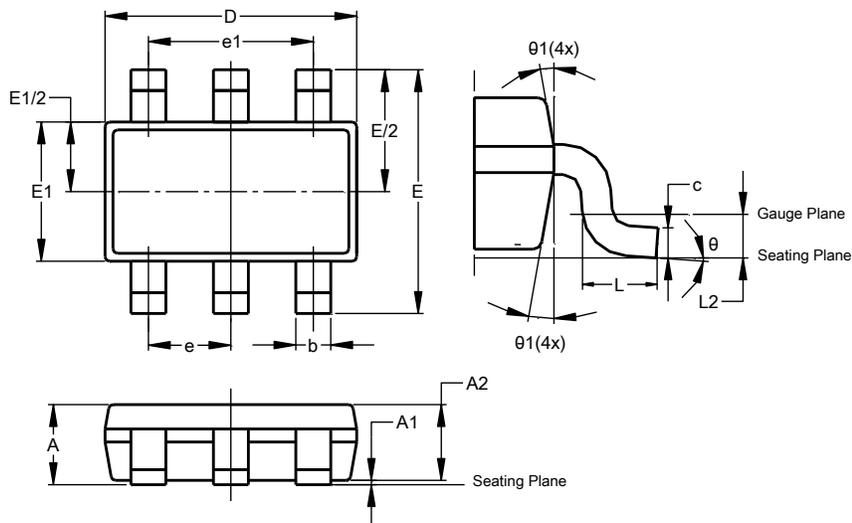


Figure 13. Transient Thermal Resistance

Package Outline Dimensions

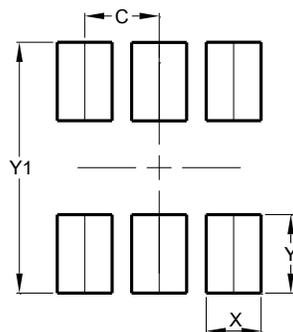
TSOT26



TSOT26			
Dim	Min	Max	Typ
A	–	1.00	–
A1	0.010	0.100	–
A2	0.840	0.900	–
D	2.800	3.000	2.900
E	2.800 BSC		
E1	1.500	1.700	1.600
b	0.300	0.450	–
c	0.120	0.200	–
e	0.950 BSC		
e1	1.900 BSC		
L	0.30	0.50	–
L2	0.250 BSC		
θ	0°	8°	4°
θ1	4°	12°	–
All Dimensions in mm			

Suggested Pad Layout

TSOT26



Dimensions	Value (in mm)
C	0.950
X	0.700
Y	1.000
Y1	3.200